

**Search Notes**

Application/Control No.

10/676,060

Examiner

Mark Ruthkosky

Applicant(s)/Patent under  
Reexamination

ARIYOSHI ET AL.

Art Unit

1745

**SEARCHED**

Class	Subclass	Date	Examiner
429	12, 34	12-05	MR

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR